

Notice of References Cited

Application/Control No.

10/588,316

Applicant(s)/Patent Under
Reexamination
MIURA ET AL.

Examiner

Min Shin

Art Unit

3688

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0033292 A1	02-2003	Meisel et al.	707/3
*	B	US-2004/0068436 A1	04-2004	Boubek et al.	705/014
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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